Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/543,190	TATEMATSU ET AL.	
Examiner	Art Unit	
Huan H. Tran	2861	

	0545			
	SEARCHED			
Class	Subclass	Date	Examiner	
347	212,155 156	1/4/2007	ННТ	
399	320,322	1/4/2007	ннт	
399	323	1/4/2007	ннт	
updated		4/26/2007	ннт	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	·		
	search_see	6/19/2007	ННТ

SEARCH I (INCLUDING SEAR	NOTES CH STRATEGY	')
·	DATE	EXMR
(347/212,155,156 or 399/320,322,323).ccls.	1/4/2007	ннт
g03g015/20.ipc.	1/4/2007	ннт
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